# MOSFET - Power, Single N-Channel, SO8-FL

30 V, 0.62 mΩ, 433 A

# NTMFS0D6N03C

#### **Features**

- Advanced Package (5x6mm) with Excellent Thermal Conduction
- Ultra Low R<sub>DS(on)</sub> to Improve System Efficiency
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

## **Applications**

- ORing
- Motor Drive
- Power Load Switch
- Battery Management and Protection

## MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise stated)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			$V_{DSS}$	30	V
Gate-to-Source Volta	ge		$V_{GS}$	±20	V
Continuous Drain		T <sub>C</sub> = 25°C	I <sub>D</sub>	433	Α
Current R <sub>θJC</sub> (Note 2)	Steady State	T <sub>C</sub> =100°C		306	
Power Dissipation $R_{\theta JC}$ (Note 2)	State	T <sub>C</sub> = 25°C	P <sub>D</sub>	200	W
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	60	Α
Current R <sub>θJA</sub> (Notes 1, 2)	Steady	T <sub>A</sub> = 100°C		42	
Power Dissipation R <sub>θJA</sub> (Notes 1, 2)	State	T <sub>A</sub> = 25°C	P <sub>D</sub>	3.9	W
Pulsed Drain Current	$T_A = 25^{\circ}C, t_p = 10 \ \mu s$		I <sub>DM</sub>	900	Α
Single Pulse Drain-to-Source Avalanche Energy (I <sub>L</sub> = 45.4 A <sub>pk</sub> )			E <sub>AS</sub>	1032	mJ
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>STG</sub>	-55 to +175	°C
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		TL	260	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

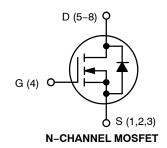
- 1. Surface-mounted on FR4 board using 1 in<sup>2</sup> pad, 2 oz Cu pad.
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

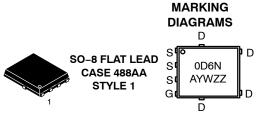


#### ON Semiconductor®

#### www.onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
30 V	0.62 m $\Omega$ @ 10 V	433 A
00 V	0.9 mΩ @ 4.5 V	400 A





A = Assembly Location

Y = Year
W = Work Week
ZZ = Lot Traceability

#### **ORDERING INFORMATION**

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

## THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 1)	$R_{ heta JC}$	0.8	°C/W
Junction-to-Ambient - Steady State (Note 1)	$R_{ heta JA}$	38	C/VV
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	134	°C/W

# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							•
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /	I <sub>D</sub> = 250 μA. ref to 25°C			12		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = 0 V,                                 $				1.0	
						100	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{G}$	iS = 20 V			100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_{D}$	= 280 µA	1.3		2.2	V
Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>	I <sub>D</sub> = 280 μA. r	ef to 25°C		-5.7		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V,	<sub>D</sub> = 30 A		0.52	0.62	mΩ
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 4.5 V,	I <sub>D</sub> = 30 A		0.72	0.9	mΩ
Forward Transconductance	9 <sub>FS</sub>	V <sub>DS</sub> = 3 V, I <sub>D</sub> = 30 A			150		S
Gate Resistance	$R_{G}$	T <sub>A</sub> = 25°C			0.4		Ω
CHARGES AND CAPACITANCES				•			•
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 15 V, f = 1 MHz			10500		pF
Output Capacitance	Coss				5740		
Reverse Transfer Capacitance	C <sub>RSS</sub>				161		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 15 V; I <sub>D</sub> = 30 A			65		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>				16		
Gate-to-Drain Charge	$Q_GD$				12		
Gate-to-Source Charge	Q <sub>GS</sub>				27		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> =	15 V; I <sub>D</sub> = 30 A		145		nC
SWITCHING CHARACTERISTICS (Note 4	1)						•
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 15 V, $I_{D}$ = 30 A, $R_{G}$ = 3.0 $\Omega$			24		
Rise Time	t <sub>r</sub>				12		1
Turn-Off Delay Time	t <sub>d(OFF)</sub>				89		ns ns
Fall Time	t <sub>f</sub>				19		
DRAIN-SOURCE DIODE CHARACTERIS	TICS						
Forward Diode Voltage	$V_{SD}$	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C		0.75	1.2	
		I <sub>S</sub> = 30 A	T <sub>J</sub> = 125°C		0.60		V
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = 0 V, dIS/dt = 100 A/μs, V <sub>DS</sub> = 15 V, I <sub>S</sub> = 30 A			97		ns
Reverse Recovery Charge	Q <sub>RR</sub>				135		nC

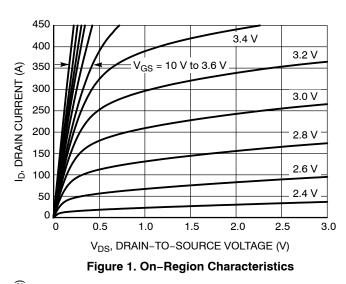
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.

4. Switching characteristics are independent of operating junction temperatures.

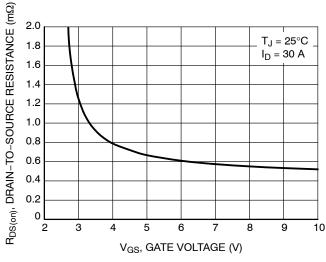
#### **TYPICAL CHARACTERISTICS**

450



 $V_{DS} = 3 V$ 400 350 D, DRAIN CURRENT (A) 300 250 200 150  $T_J = 25^{\circ}C$ 100 50  $T_J = 125^{\circ}C$  $T_J = -55^{\circ}C$ 0 1.0 0.5 2.5 3.0 0 1.5 2.0 4.0 V<sub>GS</sub>, GATE-TO-SOURCE VOLTAGE (V)

Figure 2. Transfer Characteristics



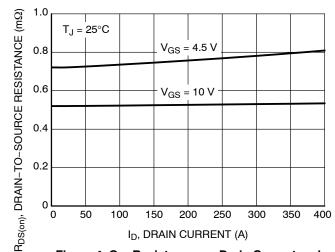
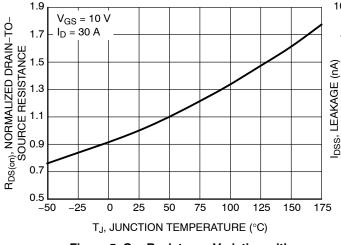


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and Gate Voltage



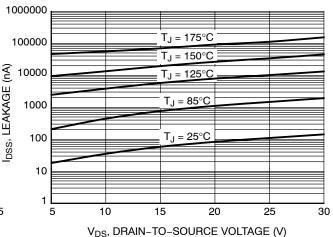


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

#### **TYPICAL CHARACTERISTICS**

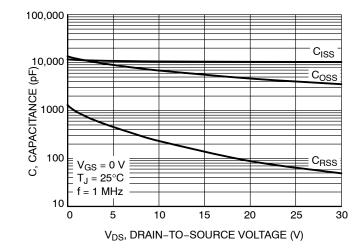


Figure 7. Capacitance Variation

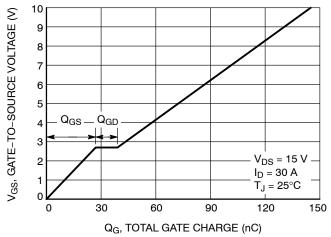


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

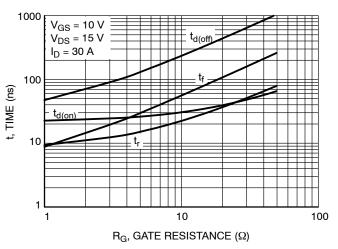


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

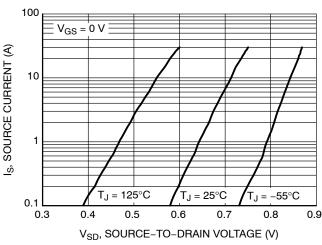


Figure 10. Diode Forward Voltage vs. Current

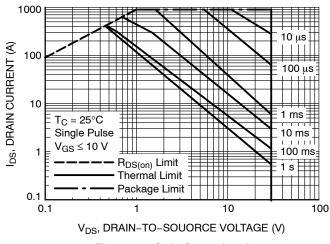


Figure 11. Safe Operating Area

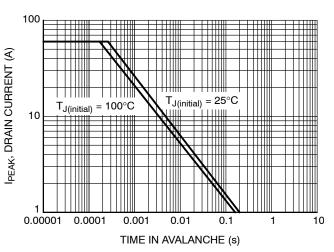


Figure 12. I<sub>PEAK</sub> vs. Time in Avalanche

# **TYPICAL CHARACTERISTICS**

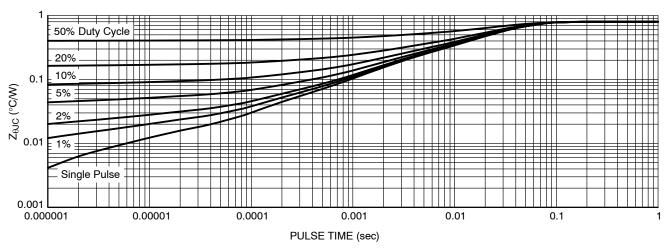


Figure 13. Thermal Characteristics

## **DEVICE ORDERING INFORMATION**

Device	Marking	Package	Shipping <sup>†</sup>
NTMFS0D6N03CT1G	0D6N	DFN5 (Pb-Free)	1500 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.



0.10

0.10

SIDE VIEW

DFN5 5x6, 1.27P (SO-8FL) CASE 488AA ISSUE N

**DATE 25 JUN 2018** 

#### NOTES:

BURRS

- DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994.
  CONTROLLING DIMENSION: MILLIMETER.
  DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE

	MILLIMETERS			
DIM	MIN	NOM	MAX	
Α	0.90	1.00	1.10	
A1	0.00		0.05	
b	0.33	0.41	0.51	
С	0.23	0.28	0.33	
D	5.00	5.15	5.30	
D1	4.70	4.90	5.10	
D2	3.80	4.00	4.20	
E	6.00	6.15	6.30	
E1	5.70	5.90	6.10	
E2	3.45	3.65	3.85	
е	1.27 BSC			
G	0.51	0.575	0.71	
K	1.20	1.35	1.50	
L	0.51	0.575	0.71	
L1	0.125 REF			
M	3.00	3.40	3.80	
A	0 0		12 °	

#### **GENERIC** MARKING DIAGRAM\*



XXXXXX = Specific Device Code

= Assembly Location Α

Υ = Year W = Work Week ZZ = Lot Traceability

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present. Some products may not follow the Generic Marking.





**DETAIL A** 

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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DESCRIPTION:	DFN5 5x6, 1.27P (SO-8FL)		PAGE 1 OF 1	

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